Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/795,777	JEONG ET AL.	
Examiner	Art Unit	
Sheela C. Chawan	2624	

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SEARCHED				
Class	Subclass	Date	Examiner	
382	154, 107	7/18/2006	scc	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST, US-PGPUB,USPAT, EPO,JPO,DERWENT,IBM-TDB.	7/18/2006	scc	
INVENTOR NAME SEARCH.	7/18/2006	scc	
		7 1,7	